

## PART NO. MVR0603-5R5E0R2

## 1. Electrical Specification

### 1-1 Test condition

Varistor voltage	In = 1 mA DC
Leakage current	Vdc = 5.5 V DC
Maximum clamping voltage	lc = 1 A
Rated peak single pulse transient current	8 / 20 $\mu$ s waveform, +/- each 1 time induce
Capacitance	10/1000 µs waveform
Insulation resistance after reflow soldering	f = 1MHz, Vrms = 0.5 V
Reflow soldering condition	Soldering paste : Tamura (Japan) RMA-20-21L Stencil : SUS, 120  µm thickness Pad size : 0.8 (Width) x 0.9 (Length) 0.8 (Distance between pads) Soldering profile : 260±5 °C, 5 sec.

## 1-2 Electrical specification

Maximum allowable continuous DC voltage	5.5	V	
trigger voltage / Varistor voltage / breakdown voltage	90-120	V	
Maximum clamping voltage	250	V	Maximum
Rated peak single pulse transient current	1	А	Maximum
Nonlinearity coefficient	> 12		
Leakage current at continuous DC voltage	< 0.1	μA	
Response time	< 0.5	ns	
Varistor voltage temperature coefficient	< 0.05	<b>%/℃</b>	
Capacitance measured at 1MHz	0.2	pF	Typical
Capacitance tolerance	-50 to +80	%	
Insulation resistance after reflow soldering on PCB	> 10	MΩ	
Operating ambient temperature	-55 to +125	$^{\circ}\!\mathrm{C}$	
Storage temperature	-55 to +125	$^{\circ}\!\mathrm{C}$	

TCR MULTILAYER CHIP VARISTORS

#### 1-3 Reliability testing procedures

Reliability parameter	Test	Test methods and remarks	Test requirement
Pulse current	Imax	IEC 1051-1, Test 4.5.	d $ Vn /Vn \le 10\%$
capability	<b>8/20</b> μs	10 pulses in the same direction at 2 pulses per minute at maximum peak current	no visible damage
Electrostatic discharge capability	ESD C=150 pF, R=330 Ω	<u>IEC 1000-4-2</u> Each 10 times in positive/negative direction in 10 sec at 8KV contact discharge (Level 4)	d   Vn   /Vn ≤ 10% no visible damage
Environmenta I reliability	Thermal shock	<u>IEC 68-2-14</u> Condition for 1 cycle Step 1 : Min40℃, 30±3 min. Step 2 : Max. +125℃, 30±3 min. Number of cycles: 30 times	d   Vn   /Vn ≤5% no visible damage
	Low temperature	$\frac{\text{IEC 68-2-1}}{\text{Place the chip at } -40\pm5^{\circ}\text{C} \text{ for } 1000\pm12\text{hrs. Remove and place for } 24\pm2\text{hrs at room temp. condition, then measure}}$	d   Vn   /Vn≤5% no visible damage
	High temperature	<u>IEC 68-2-2</u> Place the chip at $125\pm5^{\circ}$ °C for $1000\pm$ 24hrs. Remove and place for $24\pm2$ hrs at room temp. condition, then measure	d   Vn   /Vn≤5% no visible damage
	Heat resistance	<u>IEC 68-2-3</u> Apply the rated voltage for $1000 \pm 48$ hrs at $85 \pm 3$ °C. Remove and place for $24 \pm 2$ hrs at room temp. condition, then measure	d   Vn   /Vn ≤ 5% no visible damage
	Humidity resistance	<u>IEC 68-2-30</u> Place the chip at $40\pm2^{\circ}$ C and 90 to 95% humidity for $1000\pm24$ hrs. Remove and place for $24\pm2$ hrs at room temp. condition, then measure	d│Vn│/Vn≤10% no visible damage
	Pressure cooker test	Place the chip at 2 atm, $120^{\circ}C$ , $85\%$ RH for 60 hrs. Remove and place for $24 \pm$ 2hrs at room temp. condition, then measure	d   Vn   /Vn≤10% no visible damage
	Operating life	Apply the rated voltage for 1000±48hrs at 125±3℃. Remove and place for 24± 2hrs at room temp. condition, then measure	d   Vn   /Vn≤10% no visible damage

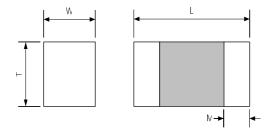
# TCR MULTILAYER CHIP VARISTORS

Mechanical Reliability	Solderability	<u>IEC 68-2-58</u> Solder bath method, 230±5℃, 2s	At least 95% of terminal electrode is covered by new solder
	Resistance to	IEC 68-2-58	d Vn /Vn≤5%
	soldering heat	Solder bath method, 260±5℃, 10±0.5s, 270±5℃, 3±0.5s	no visible damage
	Bending strength	<u>IEC 68-2-21</u>	d Vn /Vn≤5%
		Warp:2mm, Speed:0.5mm/sec, Duration: 10sec. The measurement shall be made with board in the bent position	no visible damage
	Adhesive strength	IEC 68-2-22	Strength>10 N
		Applied force on SMD chip by fracture from PCB	no visible damage

# 2. Material Specification

Body	ZnO based ceramics	
Internal electrode	Silver – Palladium	
External electrode	Silver – Nickel – Tin	
Thickness of Ni/Sn plating layer	Nickel > 1 $\mu$ m, Tin > 2 $\mu$ m	

# 3. Dimension Specification



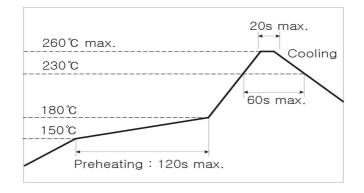
Size	L(mm)	W(mm)	T(mm)	M(mm)
0402	$1.0 \pm 0.10$	$0.5 \pm 0.10$	≤ 0.6	$0.20 \pm 0.10$
0603	$1.6 \pm 0.15$	$0.8 \pm 0.15$	≤ 0.9	$0.35 \pm 0.10$

# 4. Soldering Recommendations

## 4-1 Soldering profile

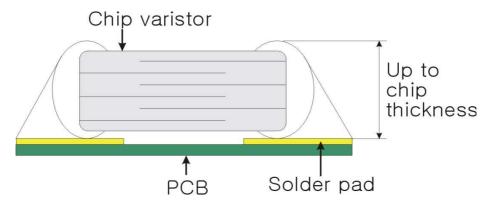


#### 4-1-1 Pb free solder paste



#### 4-1-2 Repair soldering

- Allowable time and temperature for making correction with a soldering iron : 350  $\,\pm\,$  10  $\,^\circ\!\mathrm{C}$  , 3 sec.
- Optimum solder amount when corrections are made using a soldering iron

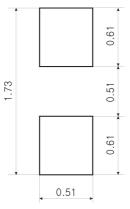


## 4-2 Soldering guidelines

- Our chip varistors are designed for reflow soldering only. Do not use flow soldering
- Use non-activated flux (CI content 0.2% max.)
- Follow the recommended soldering conditions to avoid varistor damage.



4-3 Solder pad layout



## 5. Storage condition

- Chip varistors can experience degradation of termination solderability when subjected to high temperature of humidity, or if exposed to sulfur or chlorine gases.
- Avoid mechanical shock (ex. Falling) to the chip varistor to prevent mechanical cracking inside of the ceramic dielectric due to its own weight.
- Use chips within 6 months.

If 6 months of more have elapsed, check solderability before use.-

## 6. Description about package label

#### Type : MVR0603-5R5E0R2

MVR: Series name 0603 : Chip size –0603 (1.6 x 0.8 mm) size 5R5 : Maximum continuous working voltage – 5.5Vdc E : Product function – E for ESD 0R2 : Capacitance value – means 0.2 pF

#### Qunatity : 4,000 pcs

- Quantity of shipping chip varistor